

Notice of References Cited	Application/Control No. 10/774,308	Applicant(s)/Patent Under Reexamination VIEIRA ET AL.	
	Examiner Hanh Phan	Art Unit 2638	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,335,819	01-2002	Cho et al.	359/333
*	B	US-6,532,091	03-2003	Miyazaki et al.	398/175
*	C	US-2002/0075558	06-2002	Kim et al.	359/332
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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